

## New copper(I) precursors for the deposition of copper films

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Copper deposition has become an important and rapidly growing area in integrated circuit manufacturing in microelectronic industry. Regarding copper(I) precursors, Lewis base stabilized fluorine-containing ( $\beta$ -diketonate) copper(I) complexes receive the most attention.<sup>[1]</sup> However, fluorine-free copper(I) precursors have recently attracted interest as a result of adhesion problems of the deposited copper layer onto TiN when using fluorine-containing copper precursors.

Therefore, a new type of fluorine-free copper(I) precursor, Lewis base stabilized copper(I) oxalate complexes, has been developed (Figure 1).<sup>[2]</sup> The X-ray single crystal structure of  $(\text{Me}_3\text{SiC}\equiv\text{CSiMe}_3)_2\text{Cu}^{\text{I}}_2(\text{C}_2\text{O}_4)$  (**1**) shows that two (alkyne) $\text{Cu}^{\text{I}}$  building blocks are bridged by an oxalate ligand.

In contrast to most other copper(I) precursors, the new compounds show excellent thermal behaviour and air stability. TGA and DSC measurements indicate a thermal stability up to 100 °C followed by a 2 step decomposition that is completed at 300 °C (Figure 2). The two step decomposition corresponds to ligand dissociation followed by an internal redox reaction (Figure 3).

The decomposition mechanism ensures a 100 % yield of copper(0). The byproducts  $\text{CO}_2$  and the neutral Lewis base are non-toxic, thus enabling a safe and environmentally friendly process. A comparison of the new fluorine-free copper(I) precursor with the presently available fluorine-containing precursor CupraSelect<sup>®</sup>  $(\text{VTMS})\text{Cu}^{\text{I}}(\text{hfac})$  will be given.

<sup>[1]</sup> see for example: IBM Corporation **1992**, US5220044; CNRS Paris **1999**, US6130345; ATM Inc. **1999**, WO0071550; Chem. Mater. **1992**, *4*, 365 and 577; Chem. Mater. **2001**, *13*, 3993.

<sup>[2]</sup> Merck Patent GmbH, **2002**, DE 10228050.

Fig. 1: Synthesis of  $\text{L}_2\text{Cu}_2(\text{oxalate})$ , L = alkyne, alkene.

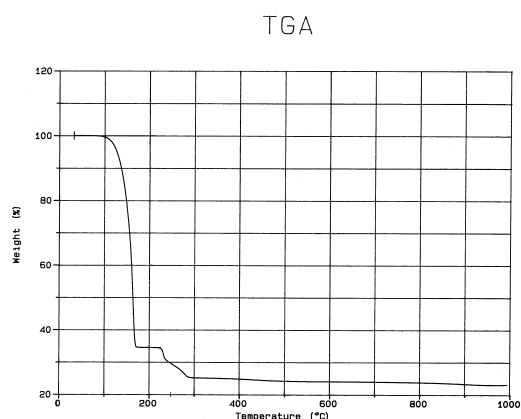


Fig. 2: Thermal analysis (TGA) of **1**.

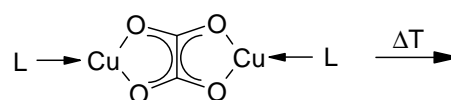


Fig. 3: Decomposition reaction of  $\text{L}_2\text{Cu}_2(\text{oxalate})$ , L = alkyne, alkene.

